

# LOW LOSS INTEGRATED OPTIC SWITCH

## Technical Field of the Invention

The present invention relates generally to  
5 optical switches, and more particularly, to a low loss  
integrated optical switch.

## Background of the Invention

Active and passive devices employing optical  
10 waveguide structures for use in communication  
applications are well known in the art. Integrated  
optical structures involve the monolithic integration of  
one or more optical waveguide structures on a common  
substrate. Optical waveguide structures include  
15 modulators and switches that typically use laser diode  
optical sources and that transmit light (i.e., an optical  
signal) along an optical fiber. An example of a passive  
structure is a fixed optical power splitter, while an  
example of an active structure is an optical switch.

20 A single substrate may include a plurality of  
optical waveguide structures and integrated optical  
directional couplers. An integrated optical directional  
coupler is formed when two optical waveguides are  
situated such that their evanescent mode fields overlap.

The distance between the two waveguides is decreased by using curved waveguides, such as "C-shaped" waveguides, that have symmetric bends, whereby each of the waveguides "bends" toward the other. The two waveguides are used to  
5 confine and guide the optical signal from an input port to an output port.

A typical configuration of an optical directional coupler has two input ports and two output ports. In this manner, light can be guided from either  
10 of the two input ports to either of the two output ports. The directional coupler can operate as a straight through switch or as a cross-over switch. When the directional coupler is activated, the selected input port and the selected output port are "coupled" so that the light  
15 received at the input port is routed to the appropriate output port.

Many applications have a requirement for a high gain optical amplifier or Q switched laser that can sustain high power pulses of short duration. In order to  
20 meet this requirement, an optical switch with very low optical throughput loss during the "on" pulse is needed.

In a conventional directional coupler acting as an optical switch, light is lost due to the bend in the waveguides. Optical loss can be high even when the

directional coupler acts as a straight through switch.  
Typical throughput loss is between three to four dB, and  
can be even higher.

A low loss integrated optical switch is thus  
5 needed which overcomes one or more of the shortcomings of  
the prior art.

BRIEF SUMMARY OF THE INVENTION

A low loss integrated optical switch in  
10 accordance with the present invention comprises optical  
waveguides formed on a substrate. One of the waveguides  
is substantially straight and connects an input port to  
an output port such that light is guided along the  
waveguide, with little throughput loss, between the  
15 ports. A second waveguide is formed in proximity to the  
substantially straight waveguide such that a directional  
coupler may be formed between the two waveguides.

BRIEF DESCRIPTION OF THE SEVERAL VIEWS OF THE DRAWINGS

20 A more complete understanding of the present  
invention may be derived from the detailed description  
and claims when considered in connection with the  
following illustrative Figures, which may not be to

scale. In the following Figures, like reference numbers refer to similar elements throughout the Figures.

FIG. 1 illustrates, in top view, an optical switch in accordance with the present invention;

5           FIG. 2 illustrates, in cross-section, the optical switch of FIG. 1;

FIGs. 3A-3F illustrate, in cross-sections, the optical switch of FIG. 1 in various stages of an indiffusion process;

10           FIGs. 4A-4F illustrate, in cross-sections, the optical switch of FIG. 1 in various stages of a proton exchange process;

FIGs. 5A-5E illustrate, in cross-sections, the optical switch of FIG. 1 in various states of the manufacturing process for electrodes; and,

FIGs. 6A and 6B illustrate, in side views, the optical switch of FIG. 1.

#### DETAILED DESCRIPTION OF PREFERRED EXEMPLARY EMBODIMENTS

20           The present invention may be described herein in terms of various hardware components and processing steps. It should be appreciated that such components may be realized by any number of hardware components configured to perform the specified functions. For

example, the present invention may employ various hardware components, e.g., electrodes, optical fibers, and the like, which may carry out a variety of functions under the control of one or more microprocessors or other control devices. In addition, those skilled in the art will appreciate that the present invention may be practiced in any number of communication contexts and that the preferred embodiment described herein is merely one exemplary application for the invention.

Accordingly, the present invention is not limited to the process flows described herein, as any process flow or rearrangement of process steps which captures the features of the present invention is considered to be within the scope of the present invention. Further, it should be noted that the present invention may employ any number of conventional techniques for processing steps such as photolithography, and the like. Such general techniques that may be known to those skilled in the art are not described in detail herein.

It should be appreciated that the particular implementations shown and described herein are merely illustrative and are not intended to limit the scope of the present invention in any way. Indeed, for the sake of brevity, conventional processing techniques may not be

described in detail herein. For example, the process of photolithographic patterning and etching is used herein in describing certain process steps in the present invention, but the process of photolithography itself, as  
5 carried out in the present invention, is not described in detail. The photolithography process includes creating a photomask containing the pattern of the component to be formed on a substrate, coating the substrate with a radiation-sensitive compound also known as a photoresist,  
10 exposing the photoresist layer to ultraviolet radiation through the mask, removing the softened portions of the photoresist, etching to remove the material left unprotected by the photoresist, and stripping off the remaining photoresist. Those skilled in the art will  
15 understand this as the process that occurs when a photolithographic step is included when describing the present invention.

As previously discussed above, a need exists for an optical switch that has a low throughput loss  
20 during the "on" pulse, and a high loss during the "off" period. During the off period, there is no requirement for using the light, so it is desirable that light does not pass through the optical switch (i.e., high optical throughput loss is created) to any optical fiber or

similar structure that may be attached to the output side of the optical switch. In accordance with the present invention, an optical switch is suitably configured to provide low optical throughput loss during an on pulse  
5 and high optical throughput loss during an off period.

In accordance with an exemplary embodiment of the present invention, with reference to FIG. 1, a low-loss optical switch 100 is illustrated. Optical switch 100 is an integrated optical device that includes a  
10 substrate 110 underlying waveguide structures 120 and 130. The substrate 110 is suitably fabricated from a material such as the widely available synthetic crystal, lithium niobate (LiNbO<sub>3</sub>), or lithium tantalate, or any other substrate material suitable for constructing  
15 optical waveguides. The optical switch 100 further comprises control electrodes 125 and 135.

The waveguide structures 120 and 130 may be formed by a titanium indiffusion process or by proton exchange as further described below. The material of the  
20 substrate 110 is determined according to the specific process that is used to form the waveguide. For example, waveguides produced by titanium indiffusion comprise photolithographically patterned lines of titanium. Alternatively, the waveguide structures 120 and 130 may

be formed by a proton exchange process that replaces lithium ions in the substrate 110 with hydrogen ions. This process produces waveguide structures with an increased refractive index, as compared to the surrounding substrate. In either configuration, the substrate 110 has an index of refraction lower than that of the waveguides 120 and 130, so that light does not escape the waveguides 120 and 130 but rather propagates through them. The thicknesses of the waveguides 120 and 130 may vary depending on the application, but an exemplary waveguide thickness is approximately 5 to 10 microns. The two waveguide structures of the optical switch 100 are located close enough to each other that the two waveguides evanescently couple to form a directional coupler.

The control electrodes 125 and 135 may comprise a metallic material such as chrome/gold, chrome/aluminum, or any other suitable material. The size of the control electrodes 125 and 135 may vary depending on the application, but exemplary sizes are approximately 5 to 15 mm for the length and approximately 10 to 50 microns for the width of the electrode.

As shown in FIG. 1, the waveguide 130 further comprises an input port 140 located at one end of the



optical switch 100 and an output port 150 located at the other end of the optical switch 100. The waveguide 130 is shaped in a substantially straight line that extends from the input port 140 to the output port 150. As will  
5 be described in detail later, an input optical fiber may be coupled to the input port 140 and an output optical fiber may be coupled to the output port 150. In this manner, the waveguide 130 may be used to guide light from the input port 140 to the output port 150.

10 The waveguide 120 has a first substantially straight section 122, a "C-shaped" section 124, and a second substantially straight section 126. The "C-shaped" section 124 is formed in proximity to the waveguide 130 such that the waveguides 120 and 130  
15 evanescently couple to form a directional coupler. The separation between the waveguides 120 and 130 may vary depending on the application, but an exemplary waveguide separation may be approximately 30 to 60 microns. The intention of the separation is to form a switch such that  
20 light can be diverted through or away from the waveguide 130.

The control electrode 125 is formed proximate to the "C-shaped" section 124 of the waveguide 120 on the side of the waveguide 120 that is away from the waveguide

130. Thus, the control electrode 125 is located such  
that the "C-shaped" section 124 extends around the  
control electrode 125. The control electrode 135 is  
formed proximate to the waveguide 130 on the side of the  
5 waveguide 130 that is away from the waveguide 120, at  
approximately the same position as the control electrode  
125.

As shown in FIGS. 3A-3F, the optical waveguides  
120 and 130 may be formed by photolithographically  
10 patterned lines of titanium (Ti) that are formed on the  
substrate 110 by a titanium indiffusion process. First,  
the substrate 110 may be cleaned and then coated with a  
photoresist 300 as illustrated in FIG. 3A. The coated  
substrate is exposed using a chrome mask 310 that is  
15 illuminated by ultraviolet (UV) radiation (FIG. 3B). The  
chrome mask 310 may be formed using standard computer-  
aided (CAD) techniques, such as those used in the  
semiconductor industry, by using a variety of equipment  
such as step-and-repeat or E-beam systems. The chrome  
20 mask 310 is a mask that corresponds to the desired  
locations of the optical waveguides 120 and 130.

The photoresist 300 is then developed to expose  
unmasked areas 322 of the substrate 110 that correspond  
to the desired locations of the optical waveguides 120

and 130 (FIG. 3C). As illustrated in FIG. 3D, the exposed areas may be removed and the patterned substrate coated with titanium 320 using equipment such as a vacuum evaporator. The titanium 320 covers the exposed regions of the substrate 110 as well as the surface of the remaining photoresist 300. As illustrated in FIG. 3E, the substrate 110 is soaked in a photoresist solvent which causes the residual photoresist 300, including the titanium 320 on top of the photoresist 300, to be removed, leaving only the titanium that coated the bare regions of the substrate 110. The photolithographed lines of titanium may be several hundred angstroms thick. As illustrated in FIG. 3F, the titanium 320 is then diffused into the substrate 110 at a high temperature, for example 1000 degrees Celsius or higher, for several hours. This diffusion process raises the refraction index in the areas where the titanium has diffused, forming high-refractive index stripes in the form of the waveguides 120 and 130 that will confine and guide light.

Alternatively, the optical waveguides 120 and 130 may be formed by using a proton exchange technique. As shown in FIGS. 4A-4F, a chrome layer 400 and a photoresist layer 410 are first deposited on a substrate 110 (FIG. 4A). Next, the coated substrate is exposed

using a chrome mask 420 that is illuminated by  
ultraviolet (UV) radiation (FIG. 4B). As noted above,  
the chrome mask 420 may be formed using standard  
computer-aided (CAD) techniques, such as those used in  
5 the semiconductor industry. The chrome mask 420 is a  
mask that contains the desired locations of the optical  
waveguides 120 and 130.

Next, the photoresist 410 is developed to  
expose unmasked areas 405 of the chrome layer 400 that  
10 correspond to the desired locations of the optical  
waveguides 120 and 130 (FIG. 4C). The exposed chrome  
areas are etched away as illustrated in FIG. 4D to define  
to define regions 408 of the substrate 110. Hydrogen  
ions are exchanged for lithium ions by submerging of the  
15 substrate 110 in hot benzoic acid 430 (FIG. 4E). The  
exchange of hydrogen ions for lithium ions results in an  
increase in the refractive index for those defined  
regions. This exchange process can take place at lower  
temperatures than the titanium diffusion. For example,  
20 this exchange process can take place at temperatures such  
as 200-250 degrees Celsius. After the substrate 110 is  
submerged in hot benzoic acid 430, the chrome 400 and the  
photoresist 410 are removed. The substrate 110 is  
annealed at a higher temperature, such as 350-400 degrees

Celsius. The regions 408 exposed to the benzoic acid have an increased refractive index to thus define the waveguides 120 and 130.

5 The electrodes 125 and 135 are formed in a similar process. That is, the substrate 110 containing the waveguides 120 and 130 may be first coated with a photoresist 500 as illustrated in FIG. 5A. Next, the coated substrate is exposed using an electrode mask 510 that is illuminated by ultraviolet (UV) radiation (FIG. 10 5B). The electrode mask 510 may be formed using standard computer-aided (CAD) techniques, such as those used in the semiconductor industry. The electrode mask 510 defines the desired locations of the electrodes 125 and 135.

15 Next, the photoresist 500 is developed to expose unmasked areas 505 of the substrate 110 that correspond to the desired locations of the electrodes 125 and 135 (FIG. 5C). The patterned substrate is now coated with a metal 520 such as chrome/gold or chrome/aluminum 20 or any other suitable metal that may be used to form electrodes (FIG. 5D). The metal 520 may be applied to the substrate 110 using equipment such as a vacuum evaporator. The metal 520 covers the exposed regions of the substrate 110 as well as the surface of the remaining

photoresist 500. Next, the substrate 110 is soaked in a photoresist solvent which causes the residual photoresist 500, including the metal 520 on top of the photoresist 500, to be removed, leaving only the metal 520 that coats  
5 the bare regions of the substrate 110 (FIG. 5E). The remaining metal 520 forms the desired electrodes 125 and 135.

As shown in FIGS. 6A and 6B, endfaces or input and output ports 140 and 150 may be lapped and polished  
10 flat into optical windows in order for light to enter and exit the waveguide 130. One technique for forming optical windows includes polishing the entire endface of substrate 110 to a sharp corner, making the whole endface into an optical window. An optical fiber can then be  
15 aligned to the end of the waveguide 130 and attached in accordance with various known techniques such as prism coupling, grating coupling, end-fire coupling with lenses, and end-fire coupling with optical fibers. These techniques are well-known in the field and will not be  
20 described in detail herein.

In operation, an input optical fiber is operatively connected to one end of the waveguide 130 at the input port 140. An output optical fiber is also operatively connected to the other end of the waveguide

130 at the output port 150. Once the optical fibers are in place, light provided by the input optical fiber can be selectively directed to the output port 150 during an "on" pulse, and the light can be leaked out of the

5 waveguide 130 during an "off" state such that light does not reach the output port 150.

Normally, light will pass from the input port 140 to the output port 150 guided by the waveguide 130. It will be appreciated that the throughput loss of light

10 guided by the waveguide 130 will be low because the waveguide 130 is substantially straight, and therefore, there is no throughput loss due to a bend in the waveguide.

When the proper voltage is provided across the

15 electrodes 125 and 135, the refractive index in the waveguide 130 is changed in the area of the electrode 135, thus causing a coupling between the waveguides 120 and 130 proximate to "C-shaped" section 124. This coupling allows the light in the waveguide 130 to couple

20 into the waveguide 120 and, therefore, light will leak out of the waveguide 130. It will be appreciated that this operation results in an "off" state whereby light does not reach the output port 150.

[illegible]